

8. SOME RECENT RESULTS AND PROBLEMS IN NOISE RESEARCH

8.1. New models and properties of 1/f noise

8.1.1. Scaling Brownian motion

1/f noise:

- no general model
- not completely understood
- very wide range occurrence in nature

=> New models required

Possibilities:

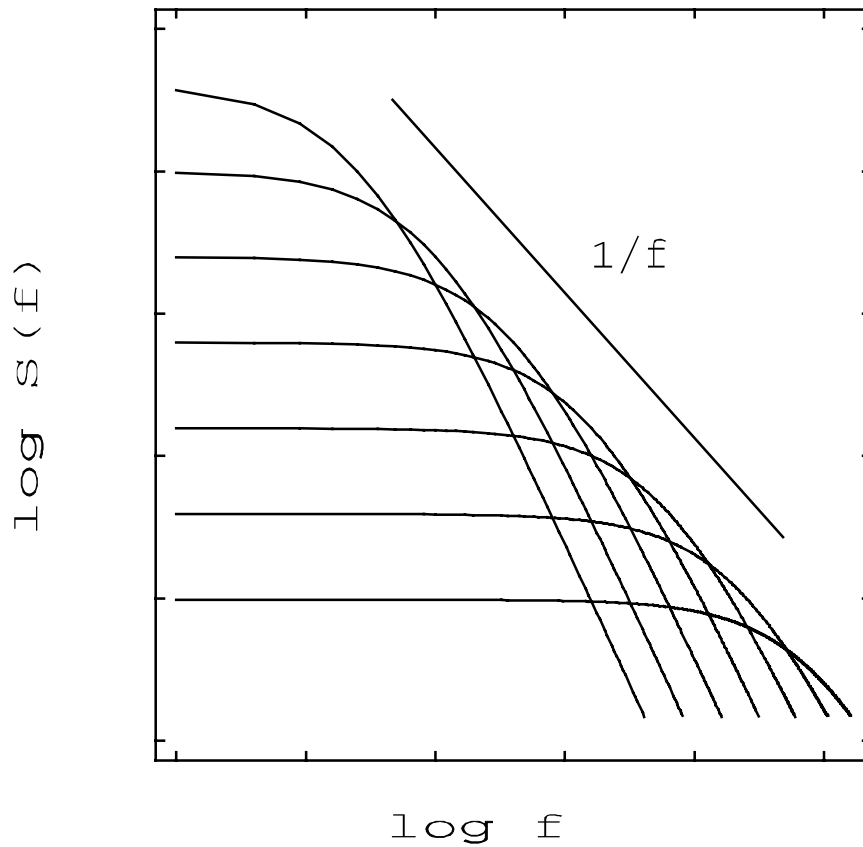
- searching for systems having $1/f$ noise inherently
- searching for a simple method for generating $1/f$ noise
- deriving $1/f$ noise from other well known noises (white, Lorentzian, $1/f^2$)

Generating $1/f^{2n}$ noise is easy:

- integrating or differentiating white noise

Other noises (e.g. $1/f^k$)

- weighted sum of Lorentzians



- non-linear transforms
- special algorithms
- solution of a differential equation

Generating 1/f noise:

try a simple recursive algorithm:

$$x(t + \tau) = f(x(t))$$

$$x_{i+1} = f(x_i)$$

e.g. random walk:

$$x_{i+1} = x_i + w_i$$

However, 1/f is not Markovian, it does not work.

Proof:

- measure $p(x_i, x_{i+1})$ for 1/f noise
- generate random variable with this distribution

$$X_{i+1} = \frac{2}{3} X_i + W_i$$

which results Lorentzian noise

Another possibility: scaling

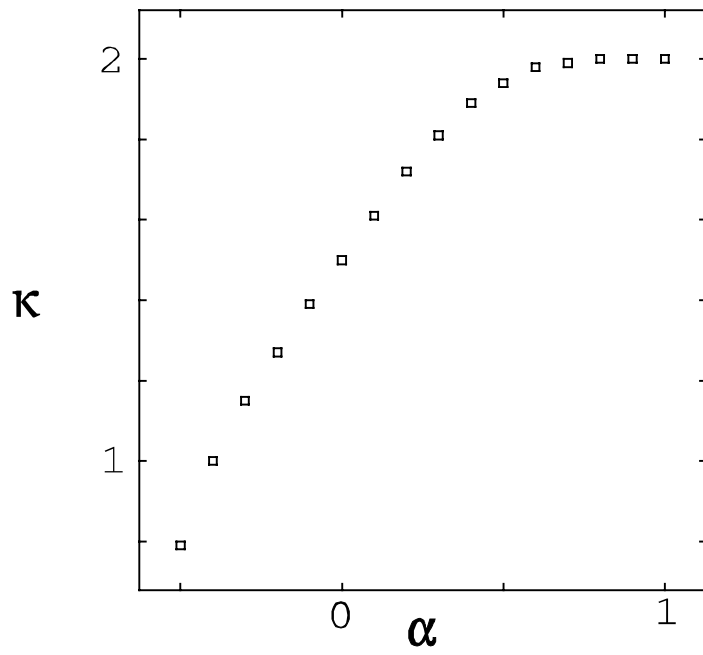
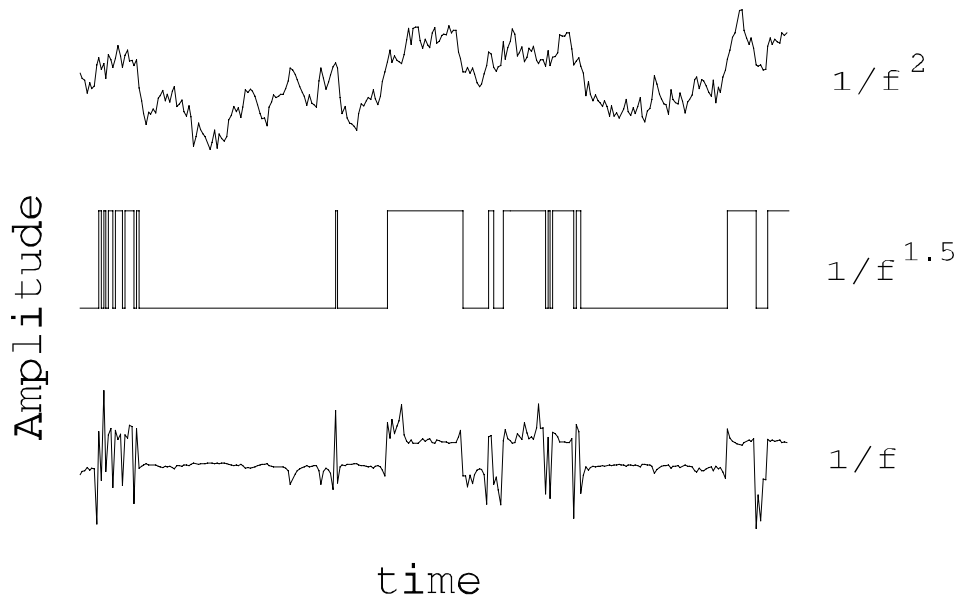
$$y(t) = f(x(t))$$

where $x(t)$ is a noise, e.g. $1/f^2$

For $1/f^k$: symmetrized power function

$$f(x) = \begin{cases} x^\alpha & \text{if } x > 0 \\ 0 & \text{if } x = 0 \\ |x|^\alpha & \text{if } x < 0 \end{cases}$$

Examples:



8.1.2. Amplitude saturation of 1/f noise

1/f^k noise

- discovered a long time ago
- general occurrence in nature

Several problems

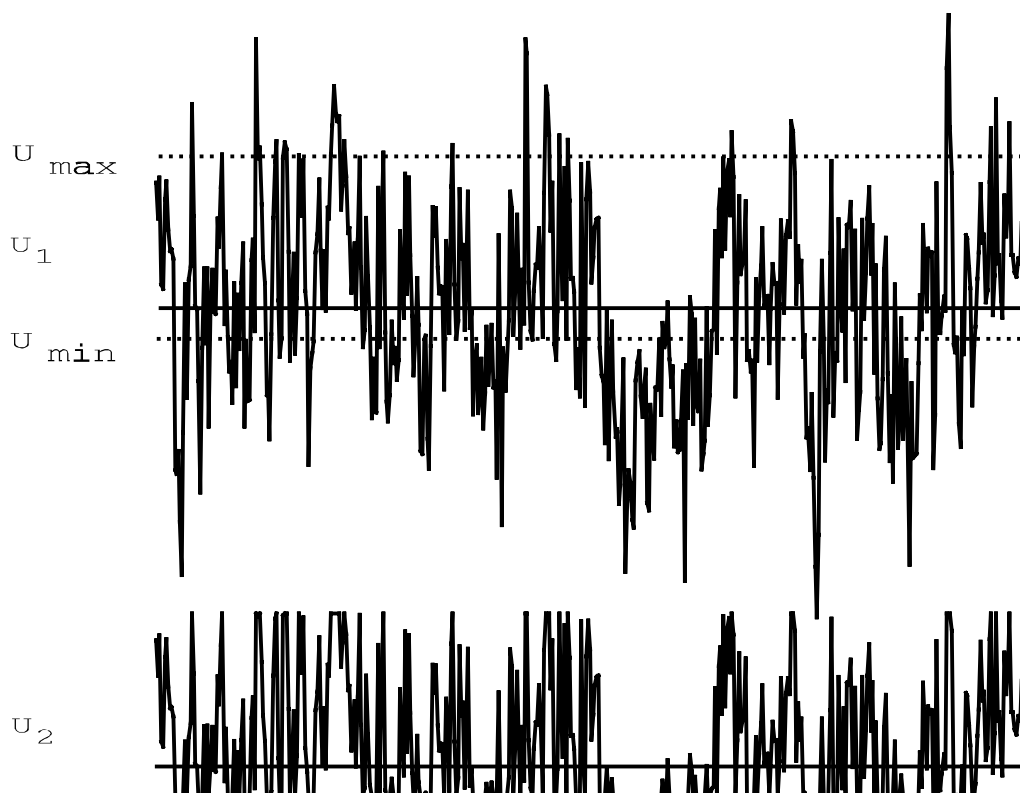
- origin not completely understood
- properties not completely known

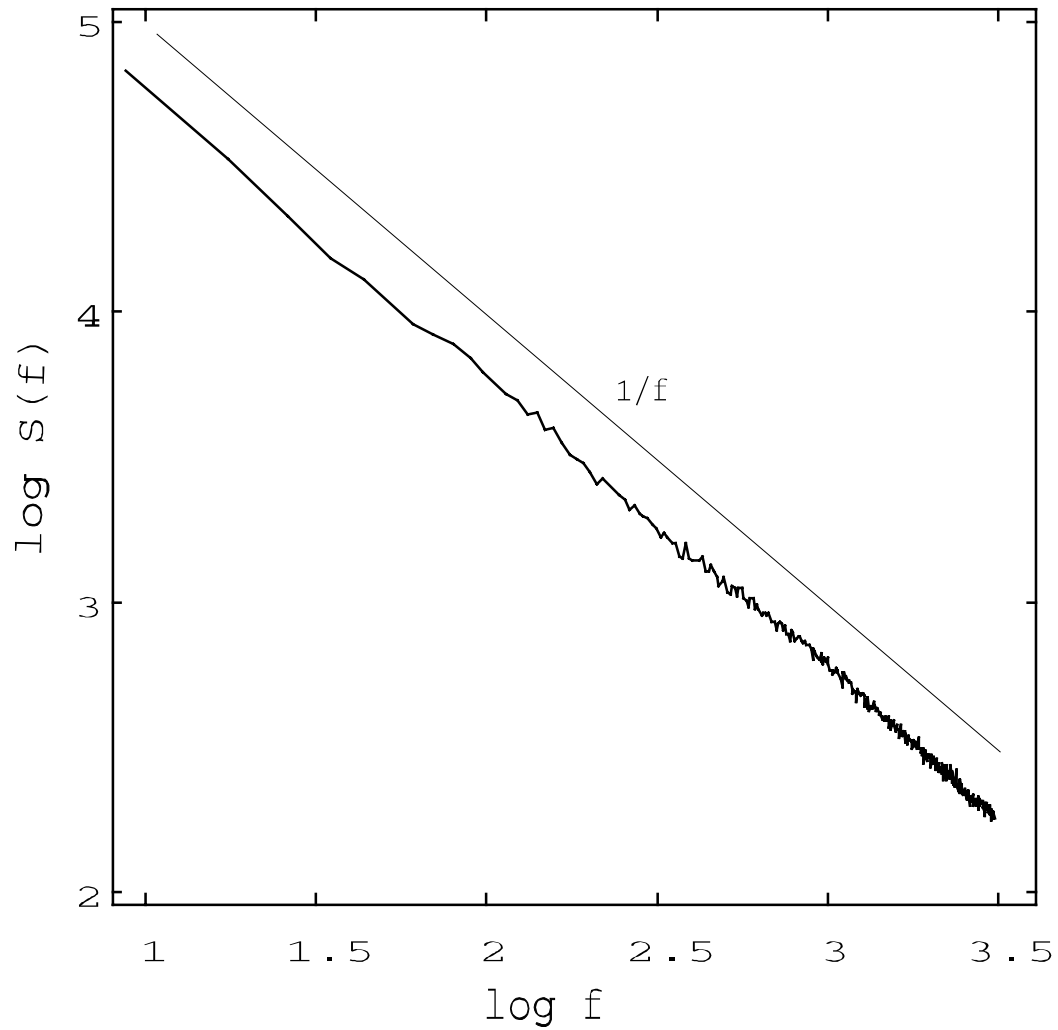
Further investigations, models required

Non-linear transformations of $1/f^k$ noises

- Amplitude distribution : usually not a problem.
- Power spectrum, autocorrelation ?

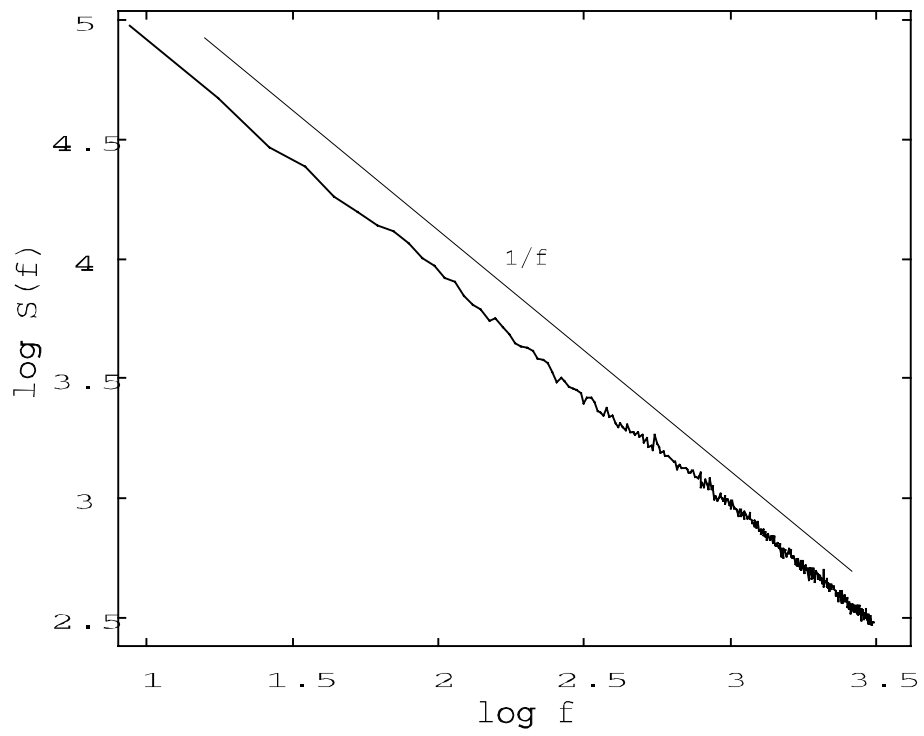
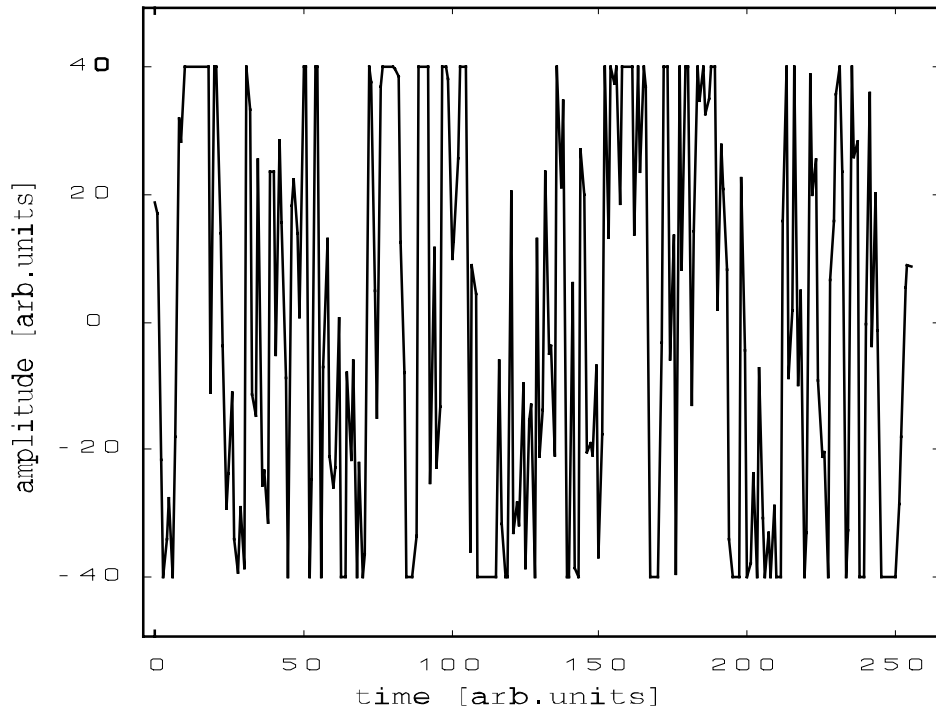
Amplitude truncation using two levels:





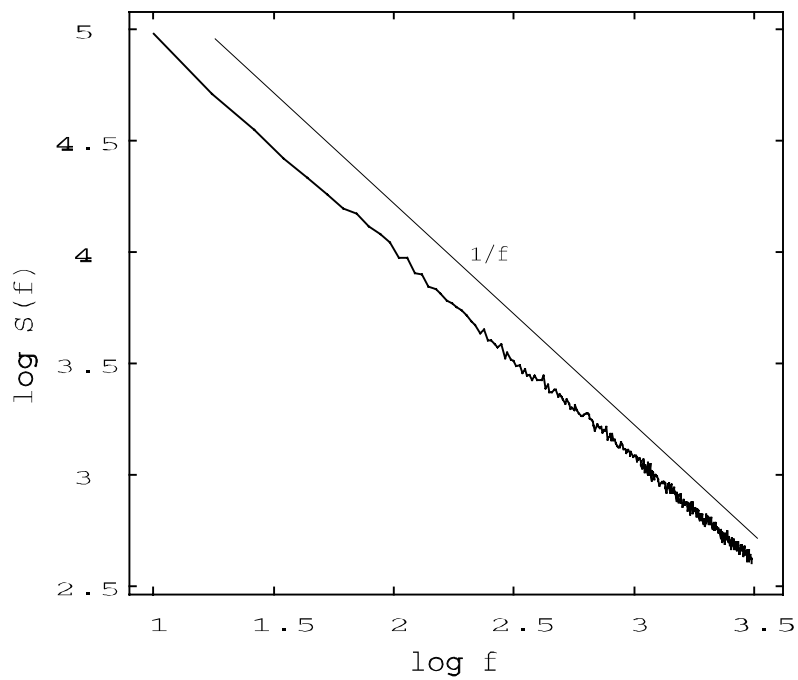
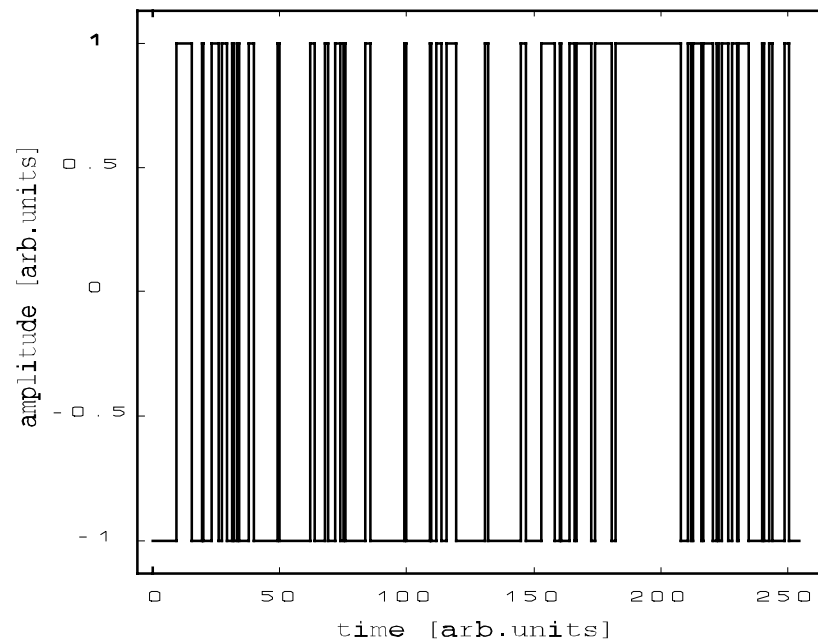
Important observation for $1/f$ noise
(simulation, measurement) :

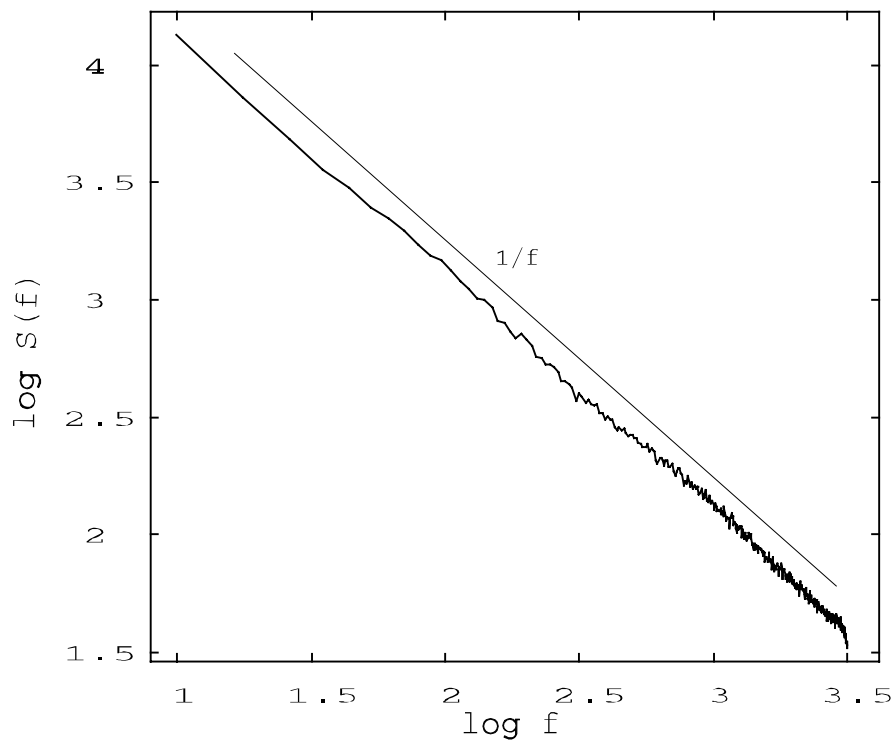
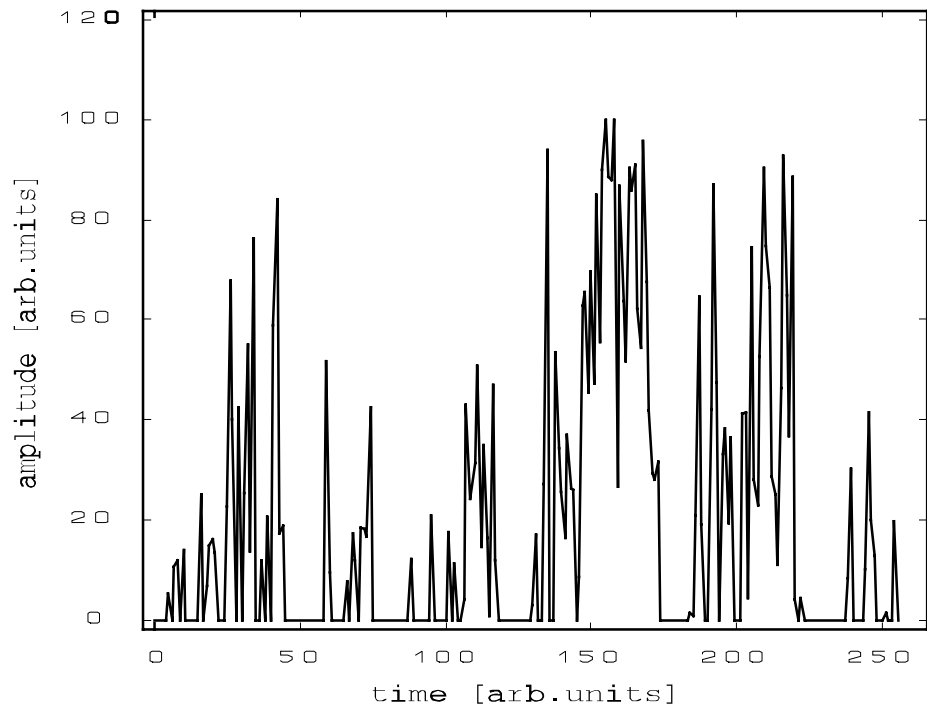
The power spectrum remains $1/f$



Preconditions?

True for any level, even for asymmetric cases.





Other $1/f^k$ noises?

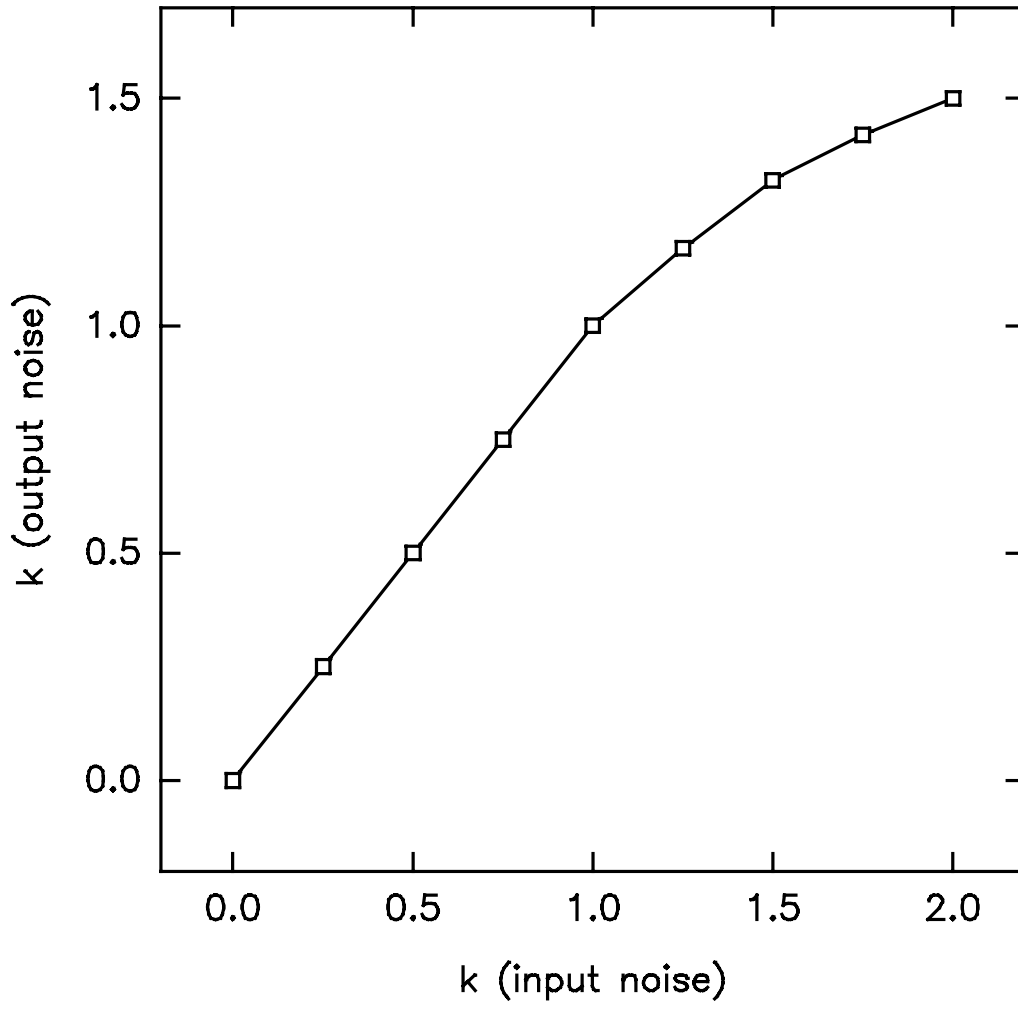
$1/f^2$: $1/f^{1.5}$, only for ZCD! (theoretical)
corner point depending on the
truncation levels.

$1/f^{1.5}$: $1/f^{1.3}$, -"- , no theory

$1/f$: $1/f$ - is it exactly true?

$1/f^{0.5}$: $1/f^{0.5}$

white : white - not surprising



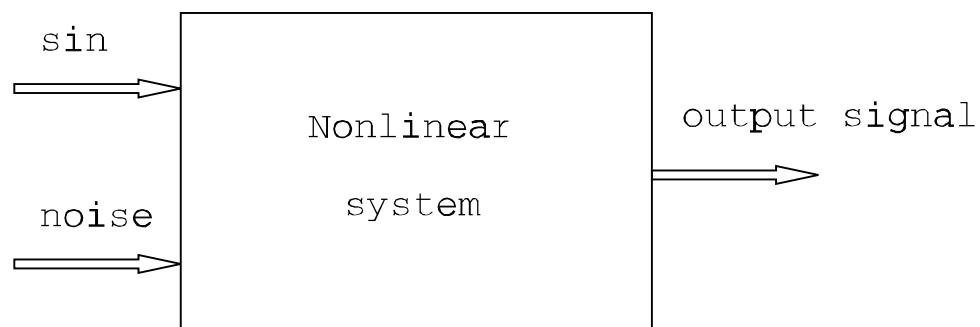
Questions, problems:

- spectrum is invariant against any truncation
 - > only the zero crossing time instants responsible for $1/f$ spectrum ?
- theory ?
- find the preconditions:
 - only gaussian noises? - There are exceptions.
 - other transformnations? / $f(x)=x^2$, .../
 - how many possibilities to "make $1/f$ from $1/f''$?
- convergence : $1/f^2$ -> $1/f^{1.5}$ -> ... -> $1/f$?

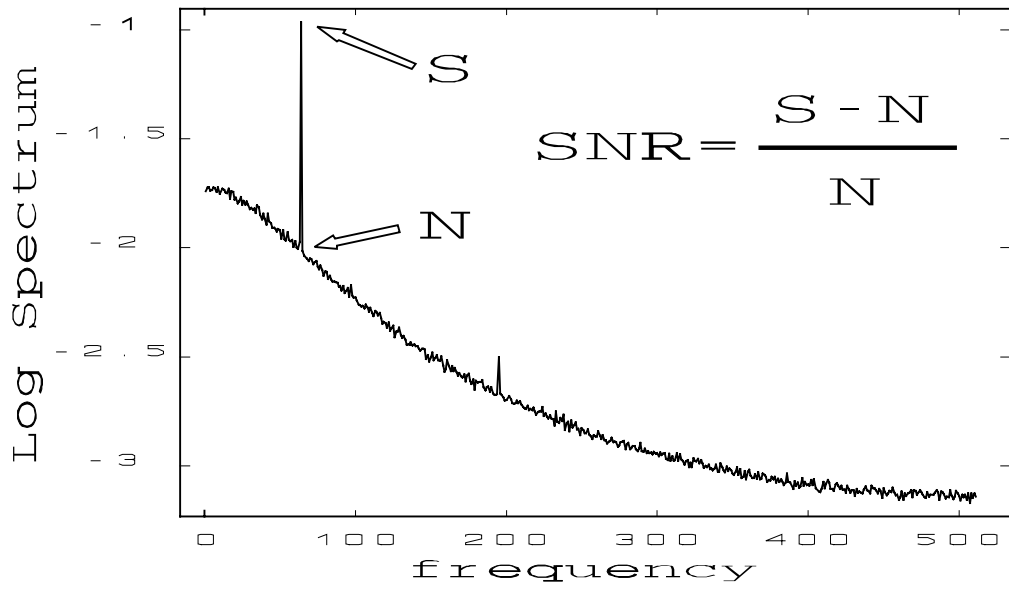
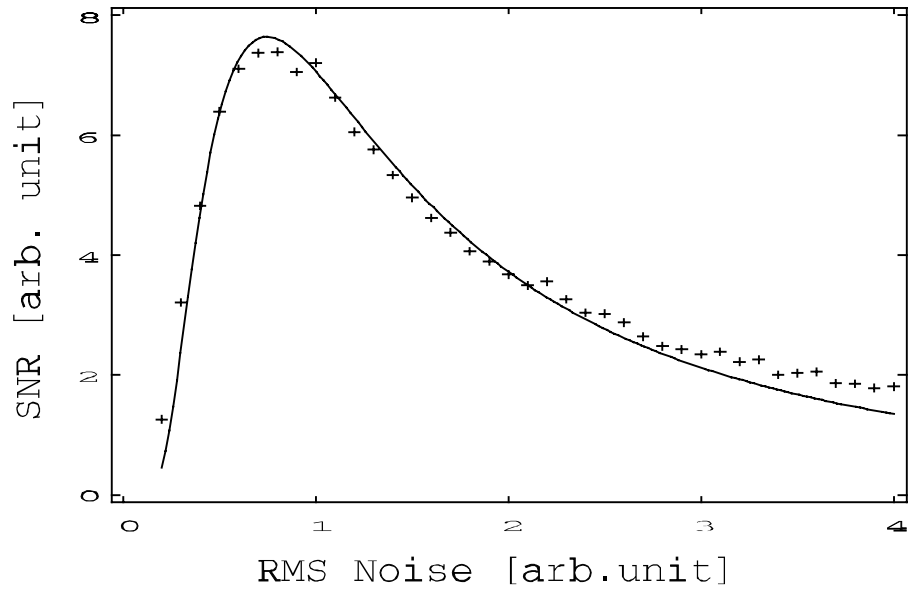
- useful to understand the generality of $1/f$ noise?
- find the systems, that can produce this kind of transformation
- experiments, further investigations required

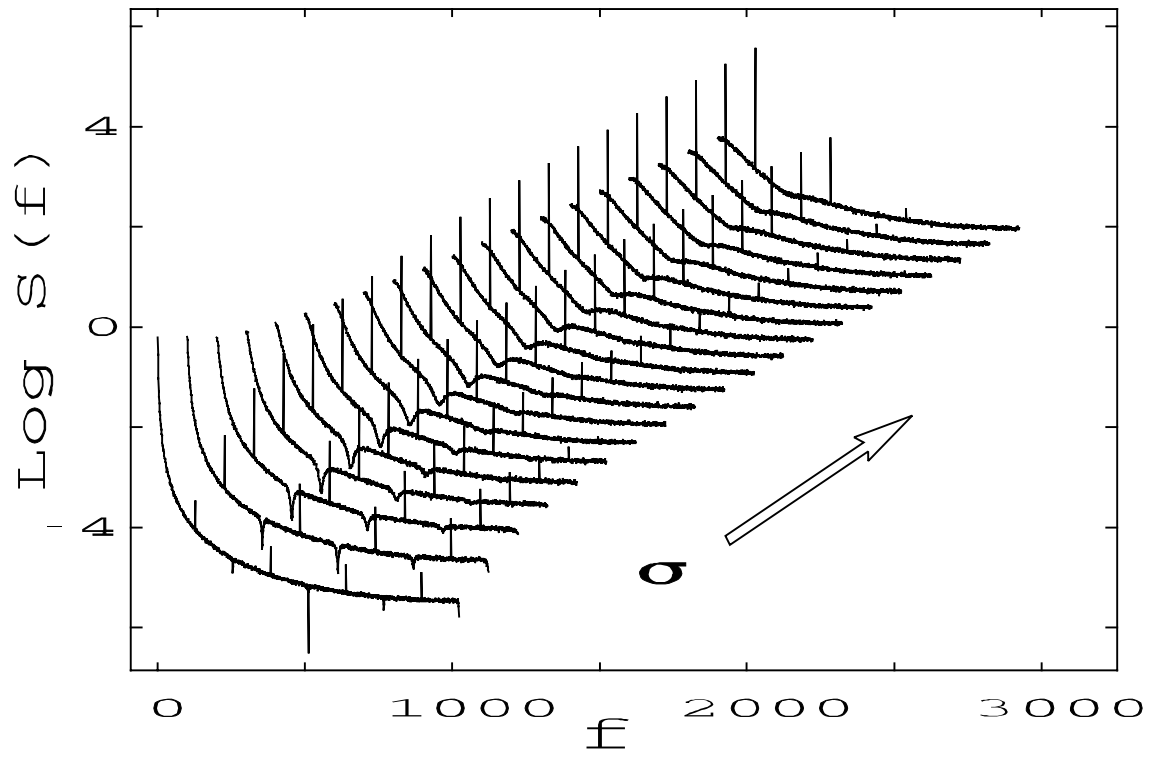
8.2. Stochastic resonance

Stochastic resonance (**SR**):



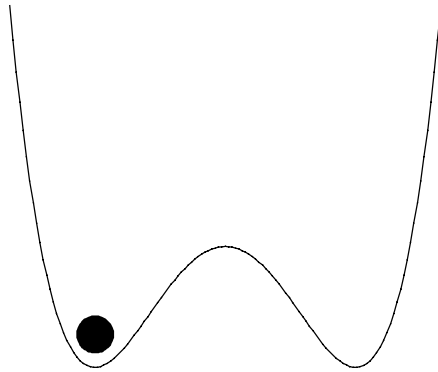
- input : periodic signal and noise
- SNR at the output (at the input frequency) has a maximum vs. input RMS of noise



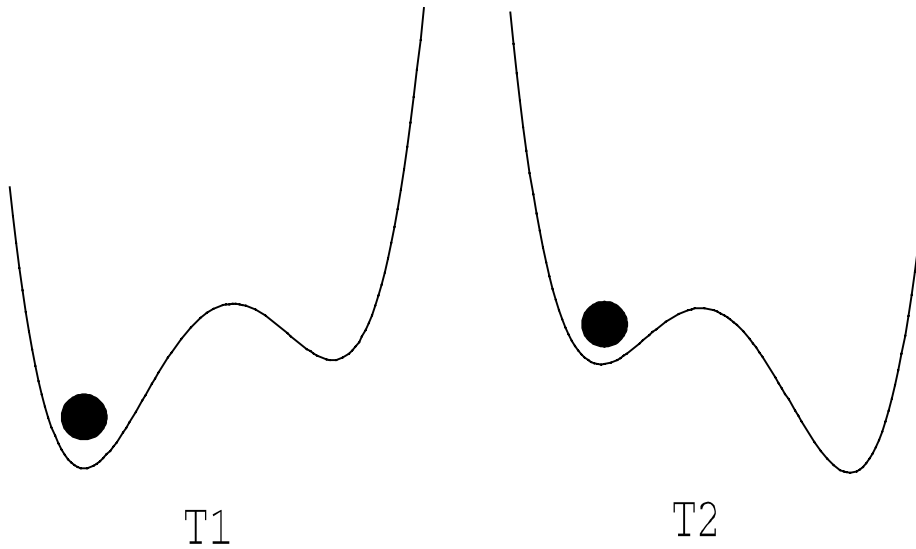


Simple bistable system producing SR

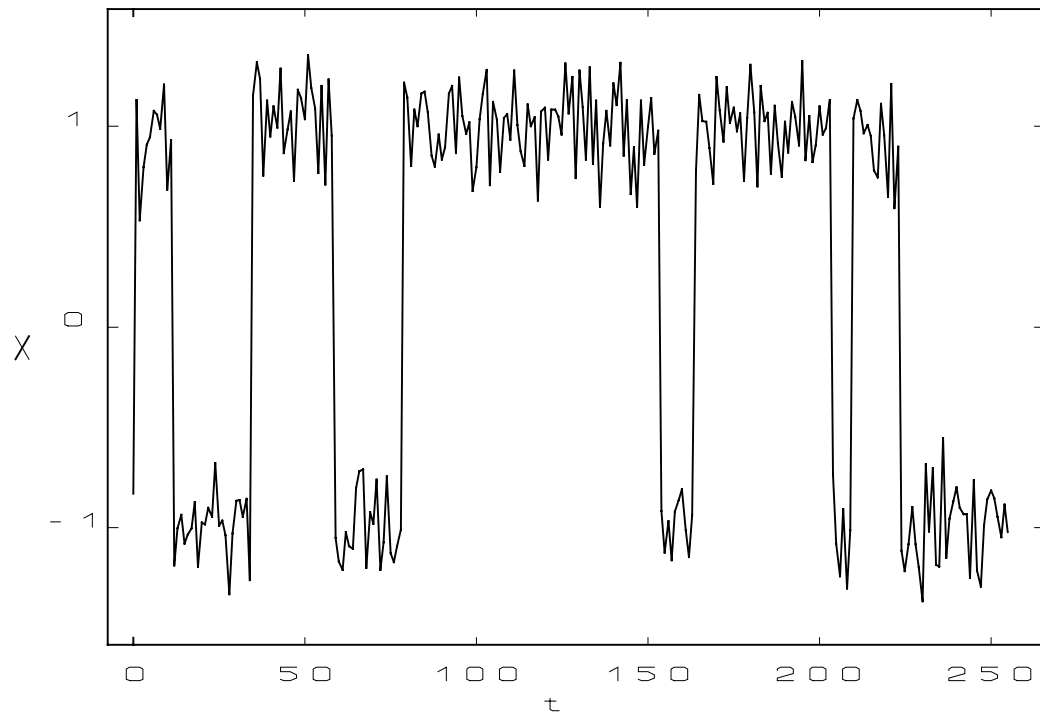
Output signal = position of the particle.

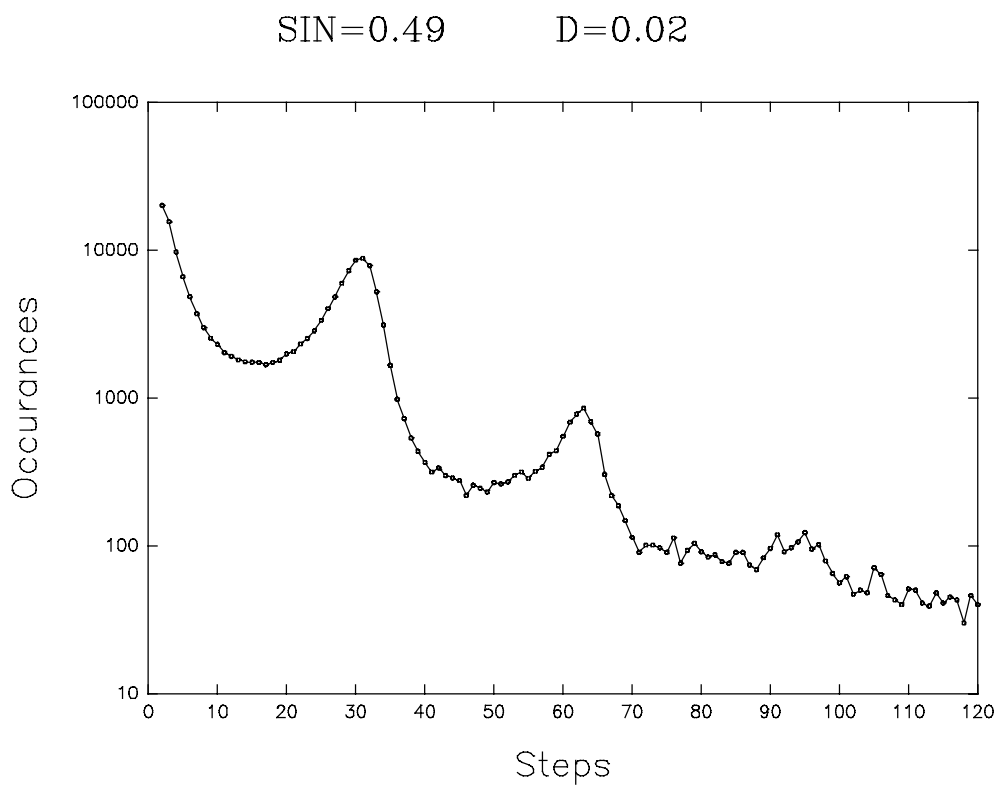
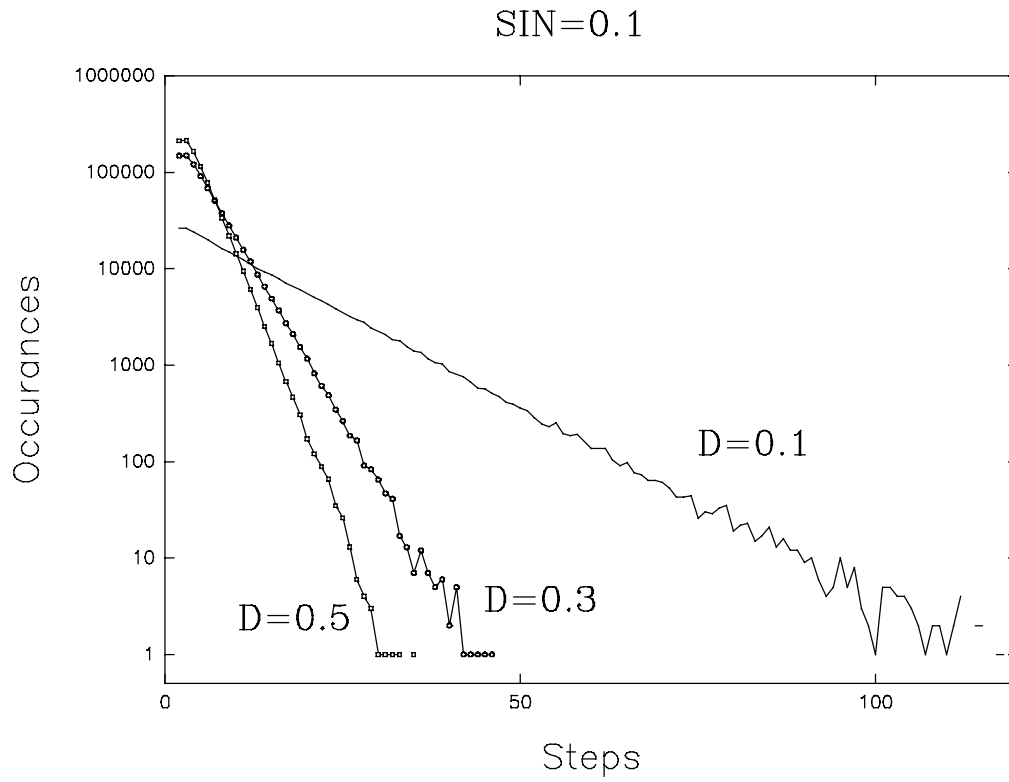


$$U(x,t) = -ax^2 + bx^4 + \epsilon x \sin(\omega t)$$



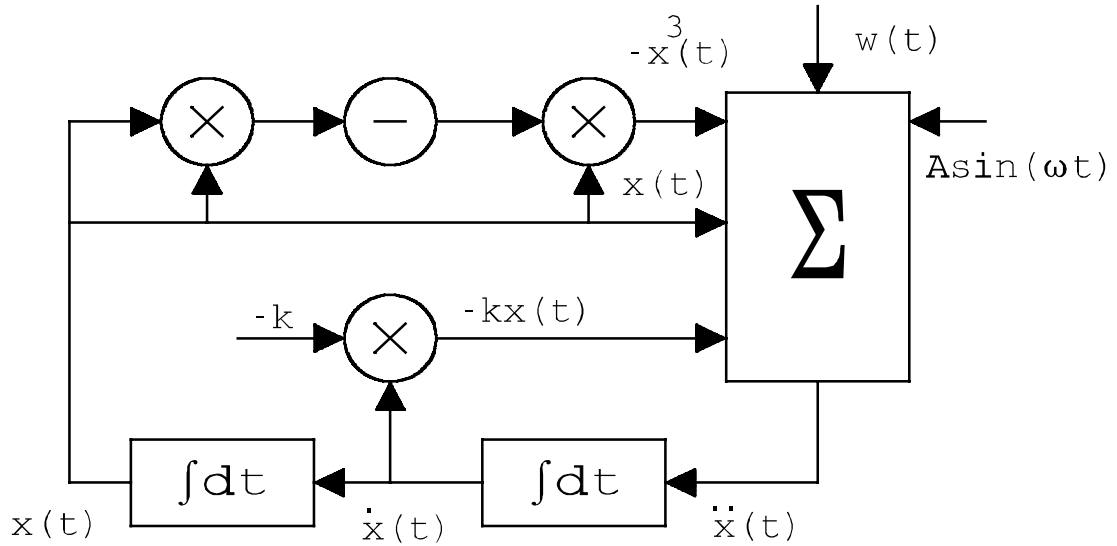
Sample output waveform





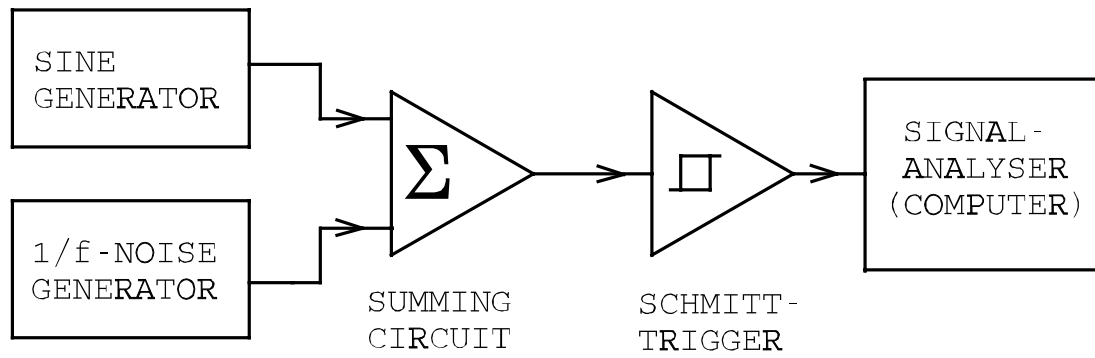
$$U(x,t) = -ax^2 + bx^4 + \epsilon x \sin(\omega t)$$

Solution by analog computer:



$$\ddot{x} = -k\dot{x} + x - x^3 + A\sin(\omega t) + w(t)$$

Analog simulations using a Schmitt-trigger:



Stochastic resonance occurs in:

- ice ages (first system for introducing SR, Benzi, Nicolis, 1981),
- meteorological phenomena
- digitized data (dithering method)
- laser with saturable absorber
- ring laser (McNamara, Wiesenfeld, Roy 1988)
- chaotic systems
- detecting noisy magnetic fields, SQUID
- biological systems, neurons (firing)
- bi- and multistable systems

Possible applications of SR

- detecting signals in noisy systems
- information processing, transmitting
- understanding physical and biological systems, proposing models

Analyzing SR theoretically and experimentally

Quantities:

$x(t)$ amplitude

$S(f)$ power spectral density

$p(x)$ probability density

$p(\tau)$ residence time statistics

SNR signal-to-noise ratio

Theories

- McNamara, Wiesenfeld adiabatic approximation
- Hanggi-Jung theory
- Dykman, LRT

Experimental analysis

- measurements in ($S(f)$, $p(\tau)$, stb.) systems showing SR (laser, SQUID, neurons, etc.)
- analog simulations (diff.eq. solutions)
- numerical simulations

New results

- SR with coloured noises (1/f, Lorentzian)
Hanggi, Moss, Kiss, Gingl, 1992
- Non-dynamical SR, Moss, Wiesenfeld,
Kiss, Gingl, 1993-1995
- Improving SNR ?, Kiss, 1995, Kiss,
Gingl, Lorincz (1996)
SNR Out > SNR In ?

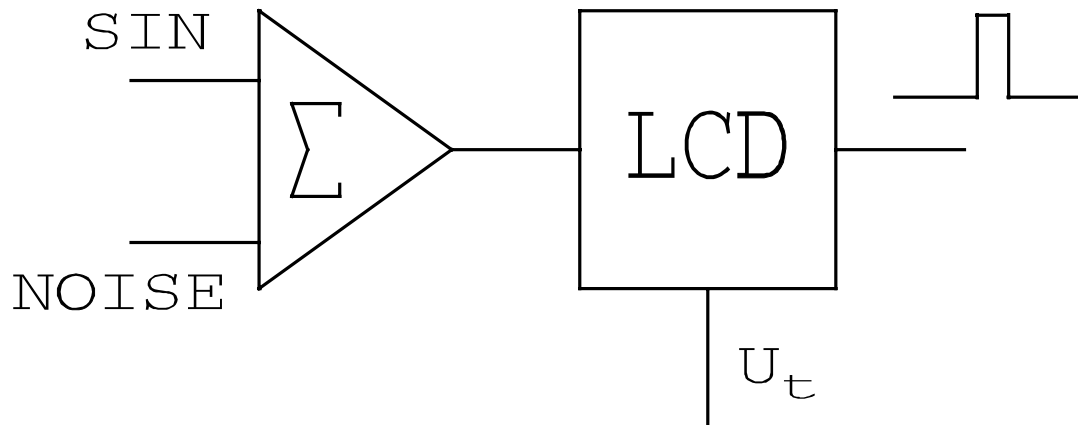
Non-dynamical SR

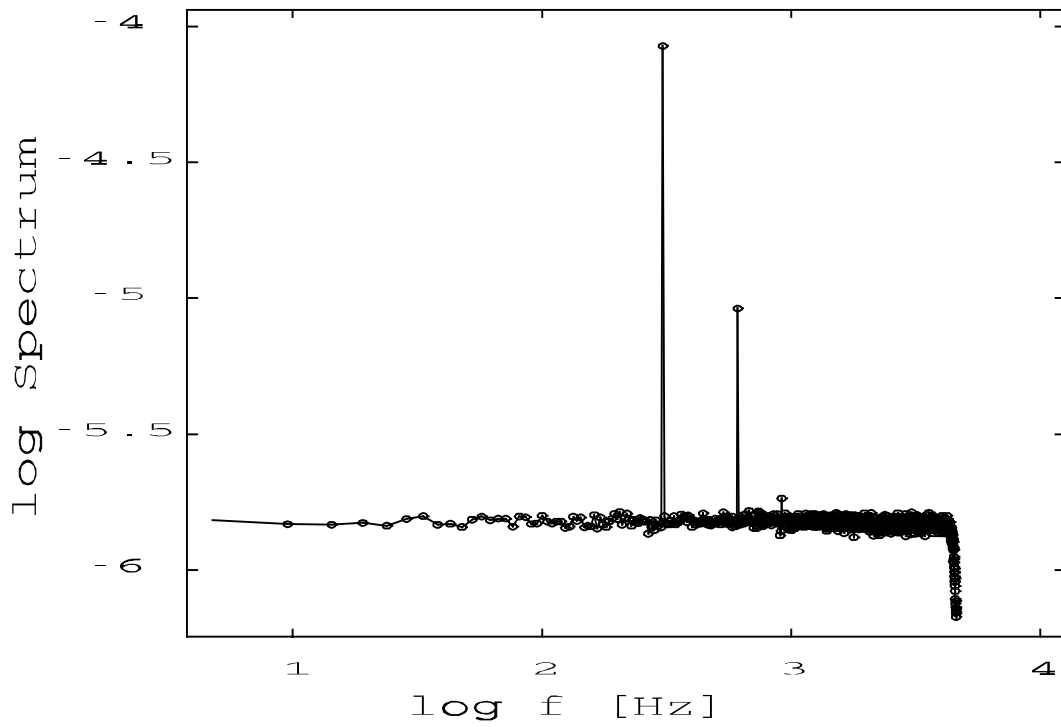
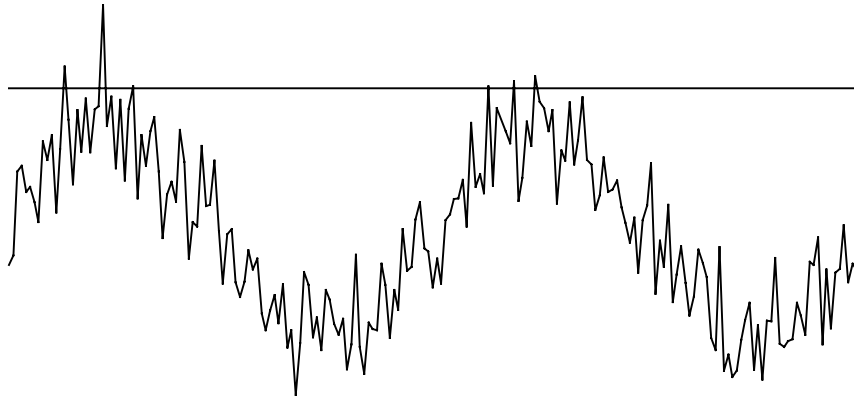
(Gingl et. al. invited talk, Int.Conf. on
Fluctuations in Physics and Biology, Elba,
Italy, 1994)

The simplest system showing SR, the level-crossing detector (LCD) (Moss, 1993)

Gaussian noise+periodic signal $>$ threshold

-> impulse at the output





Theory (Kiss, 1994)

- slow, weak modulation of frequency of the pulses, Gaussian noise

$$U_{AV} = vA\tau \quad \Rightarrow \quad U_{AV}(t) = v(t)A\tau$$

- theoretical result: S-N and SNR

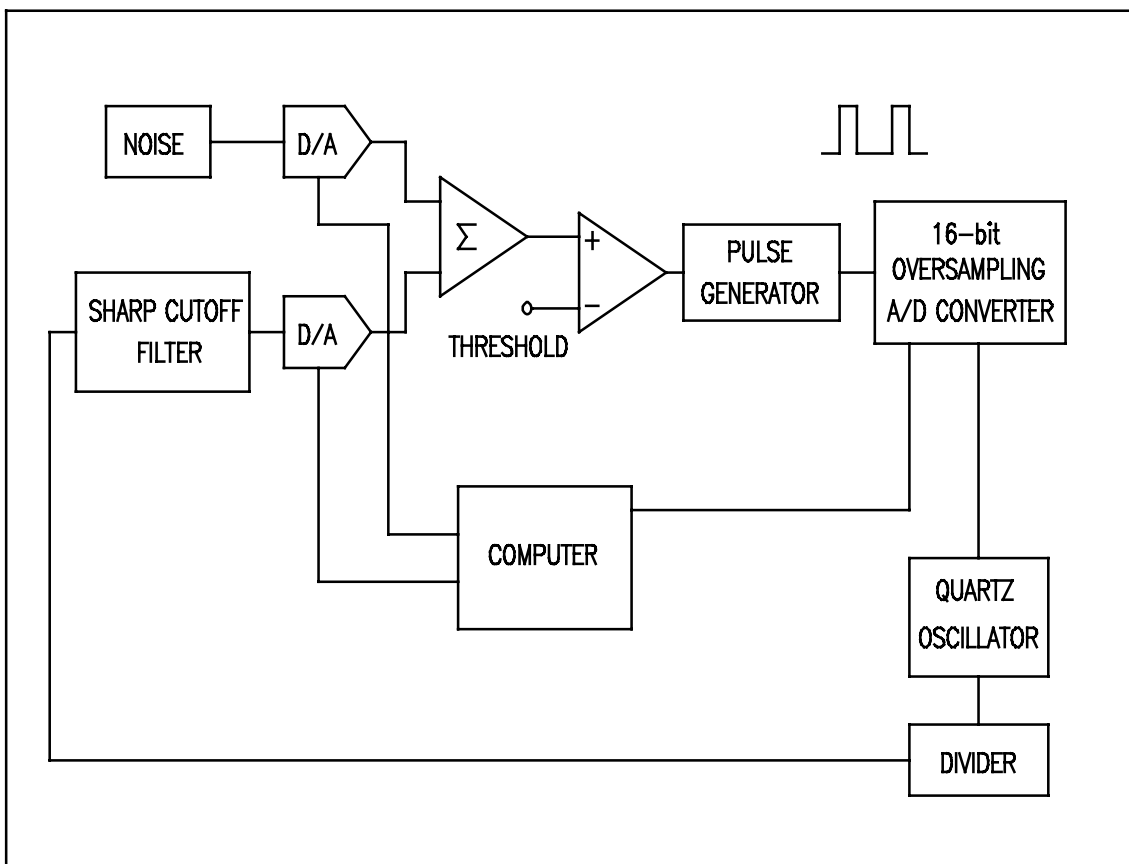
$$S-N = \frac{\text{const } e^{-(U_t/D)^2}}{D^4}$$

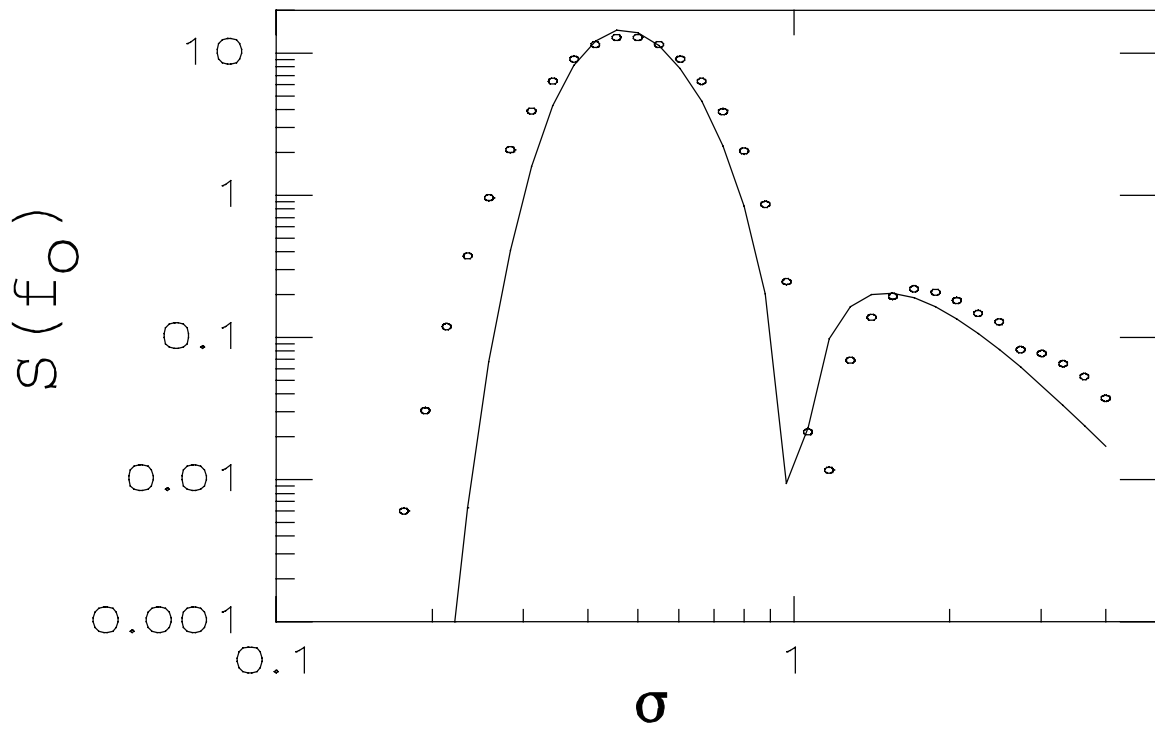
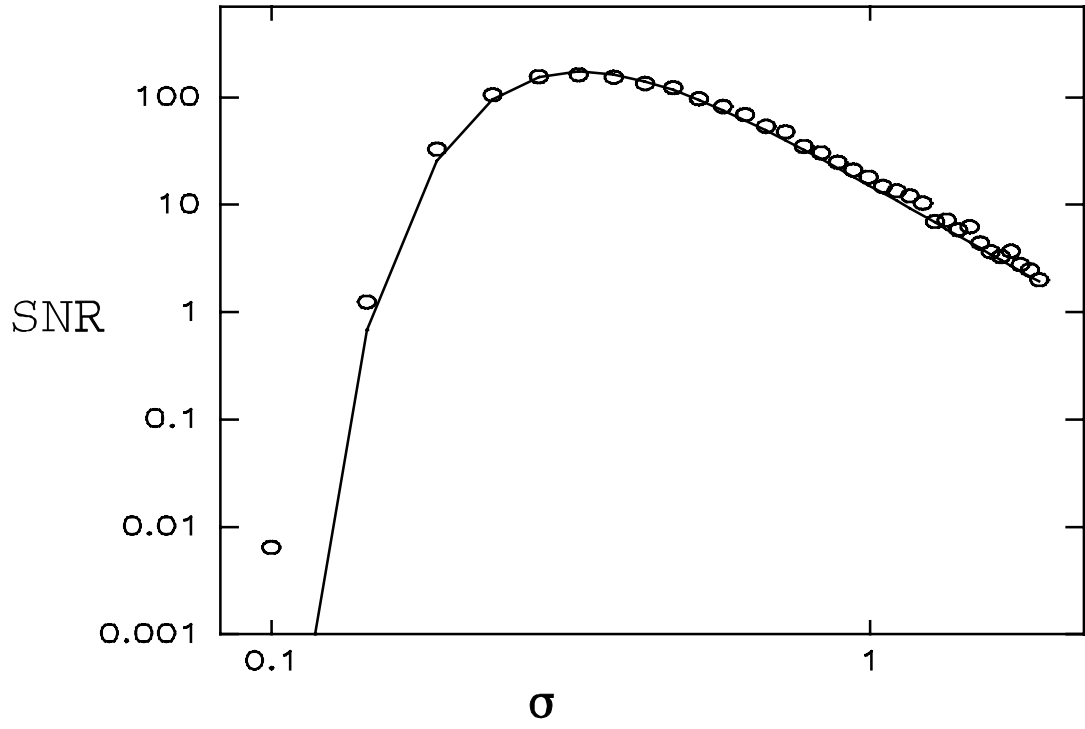
- second harmonic: two maximums in SNR (Lőrincz)

$$S-N = \text{const} \frac{(U_t^2 - D^2)^2 - (U_t/D)^2}{D^8}$$

Experimental study (Gingl, 1994)

- analog and numerical simulations
- verification of theory, extensions





LCD SR system

Fundamental SR system:

- extension of SR (new system)
- simplest
- non-dynamical
- process independent of frequency
- theory: linear, adiabatic approximation
- level-crossing also in dynamical systems
- SR depends on the level-crossing statistics of noise, even in dynamical systems

8.3. Biased percolation model of device degradation

Failure of electronic devices

(resistors, transistors, contacts, ICs)

Problems : (critical apps.)

- is the device reliable?
- how close the device to the failure?
- excitations to test state? (in use; affect state)
- what we need to be measured?

/R, σ , T, δR , S(f), .../

New percolation model (1995,

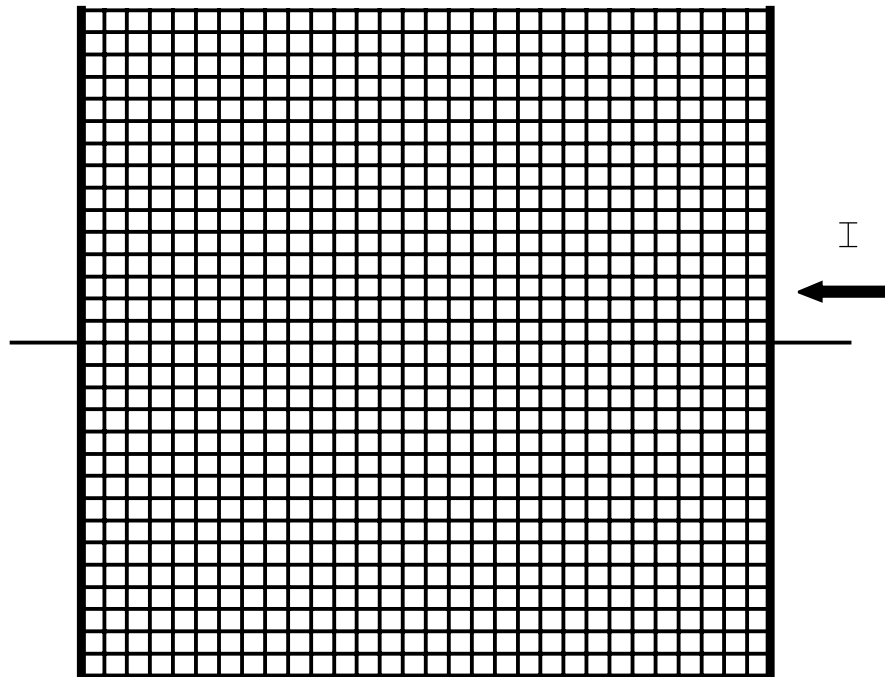
NODITO,Brno)

Percolation :

- randomly changing state of elements of a structure
- successful applications in many systems (spin, high Tc superconductors, phase transitions, ...)

Homogeneous thin film resistors

Simple model, network of uniform resistors



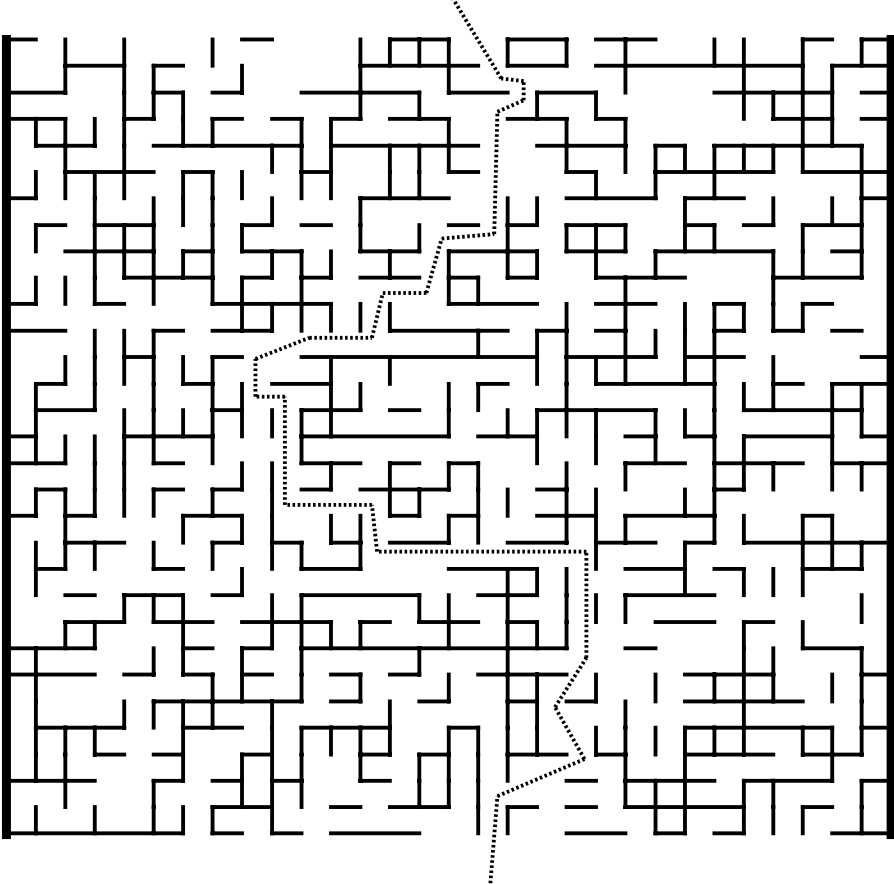
Time evolution of state

position of elements : i,j

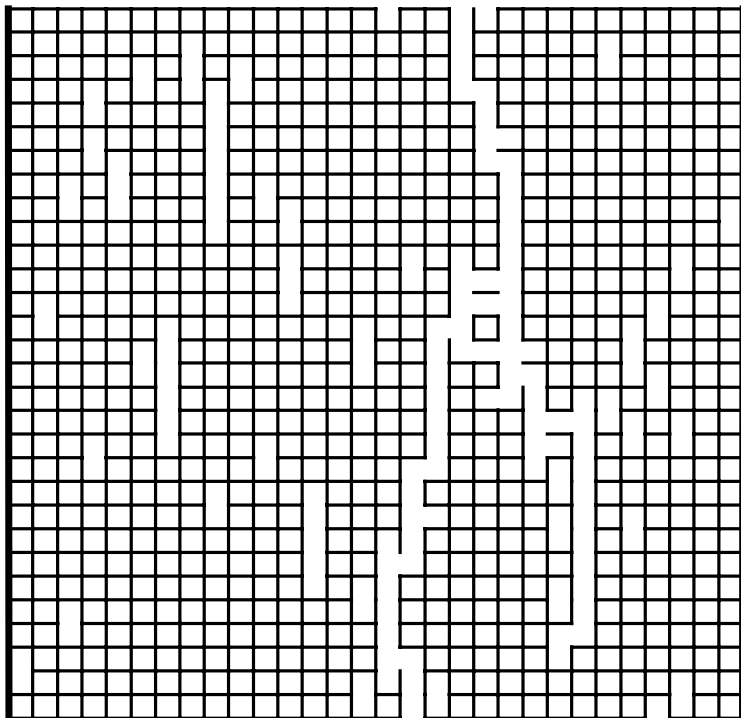
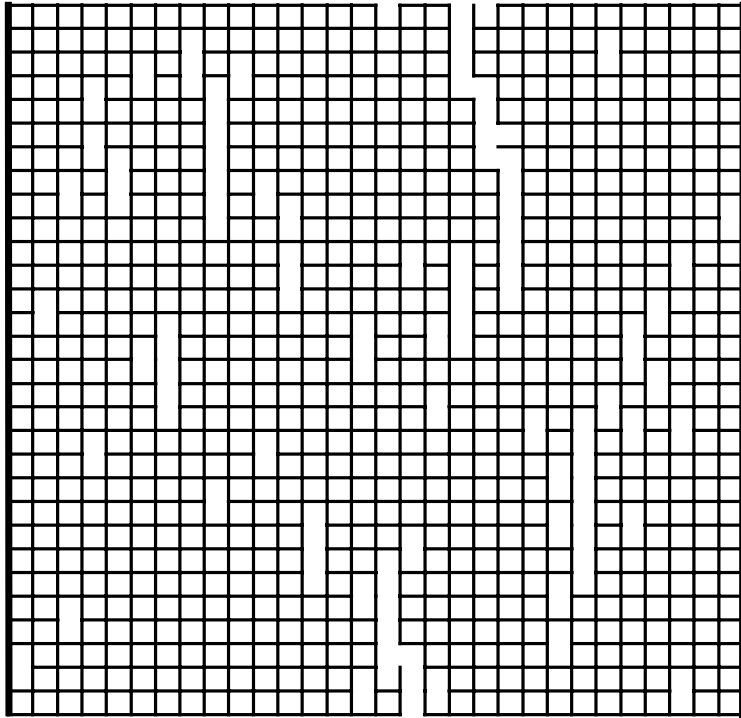
probability of failure of an element : $p_{i,j}$ of
 $R_{i,j} \rightarrow \infty$

- $p_{i,j} = \text{const}$ \rightarrow "free" percolation
 - $p_{i,j} = p_0 \exp(-E_0/kT_{i,j}) \rightarrow$ "biased" percolation
- $$T_{i,j} = T_0 + B * I_{i,j}^2 * R_{i,j} \quad \text{Joule-heating}$$

Free percolation



Biased percolation



Monte-Carlo simulations

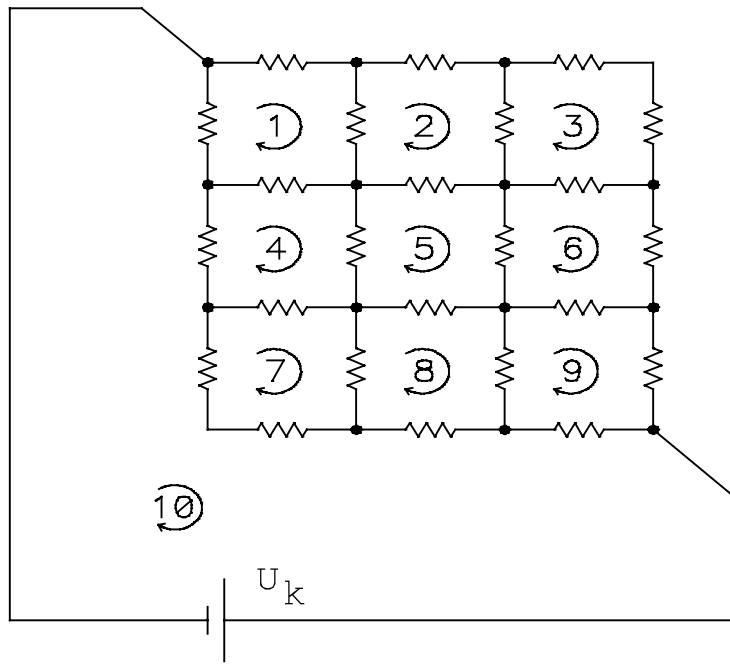
Random decisions using $p_{i,j}$ values in every step, transform the lattice to the new state:

- we have a given state of the sample,
then

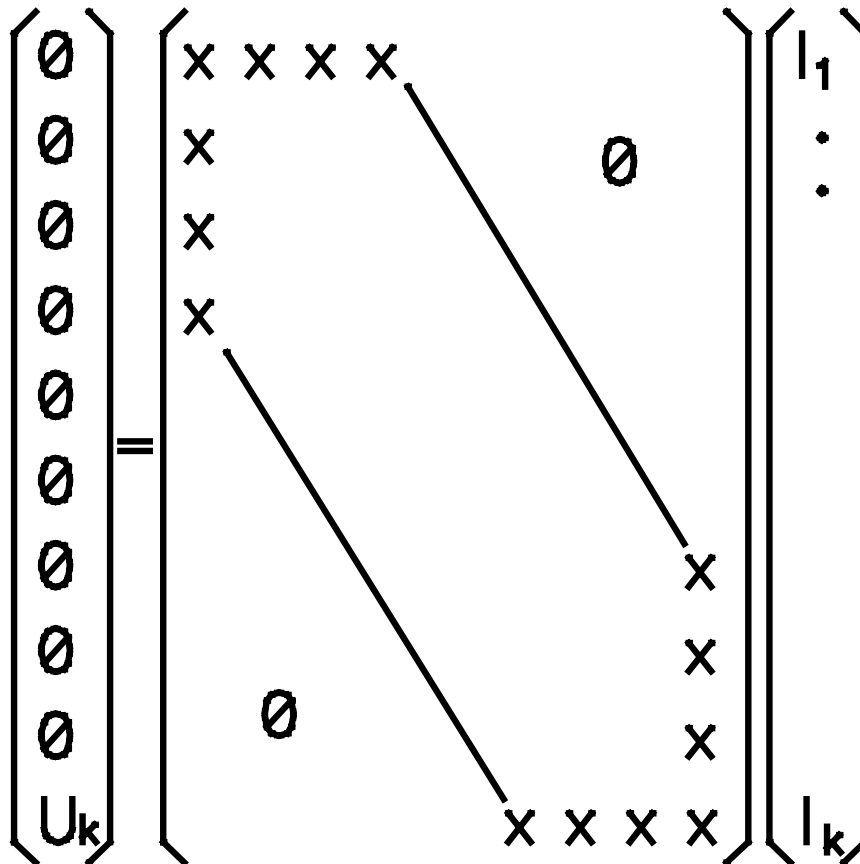
1. calculate all currents flowing in resistors
2. calculate all probabilities $p_{i,j}$
3. change the state of all resistors randomly using $p_{i,j}$

How to calculate the currents?

$N=3$



$$U=R*I$$



Size of network : $n \times n$

equations : $k=n^2+1$

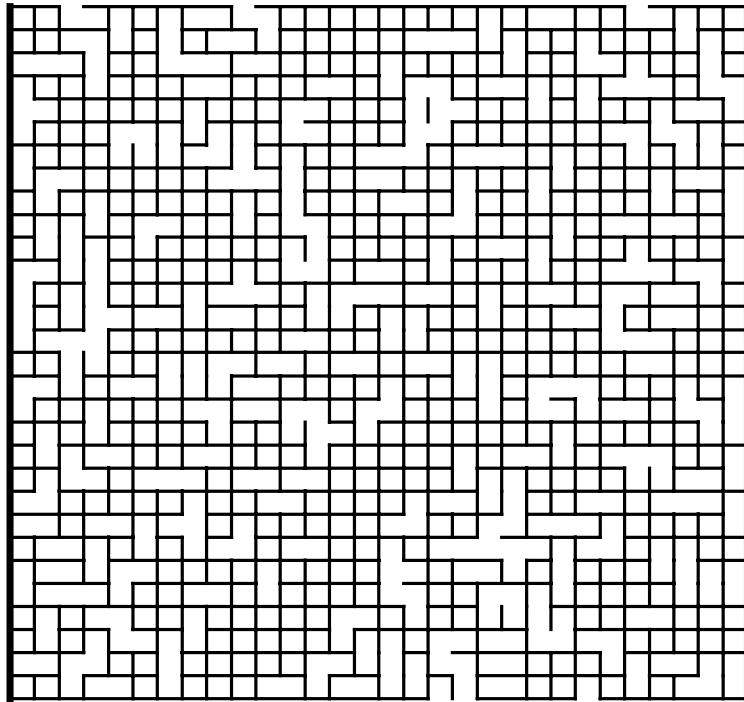
resistors : $2n(n+1)$

>0 coeffs.: $< (2n+1)(n^2+1)$ vs. $(n^2+1)^2$

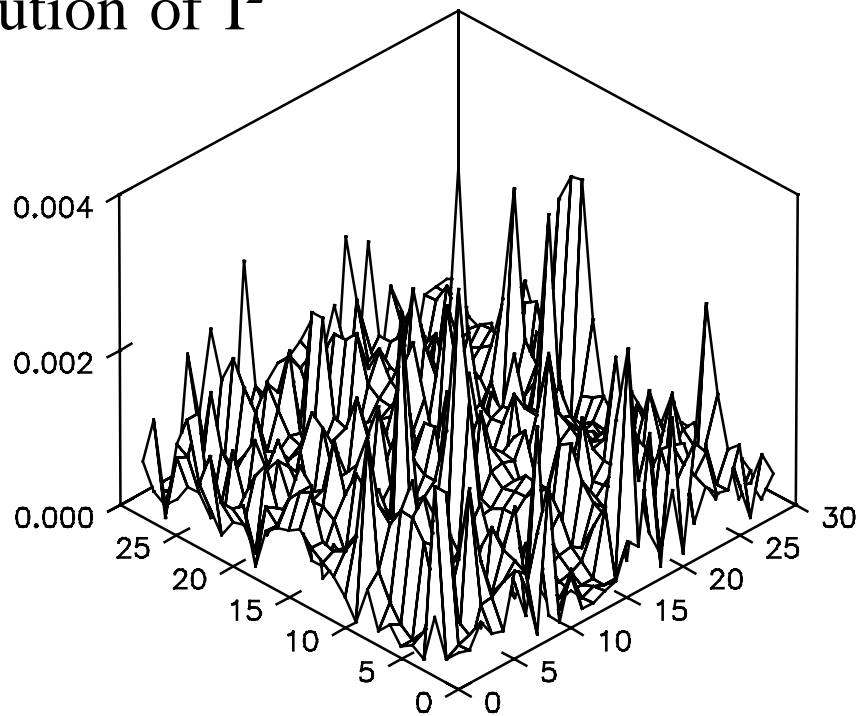
Operations: $< (2n+1)^2(n^2+1)/2$ vs. $(n^2+1)^3/2$

100x100 -> 20200 resistors, 10001 equations

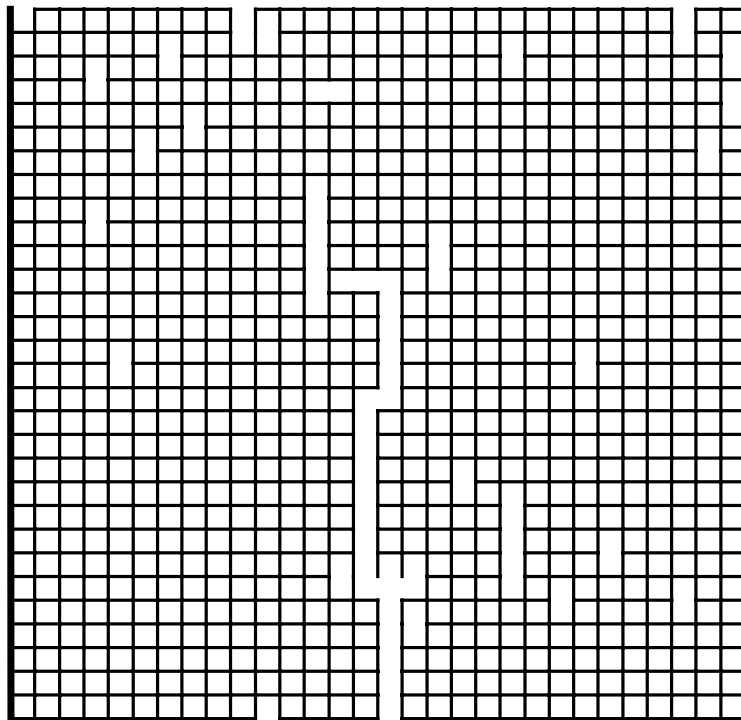
Free percolation



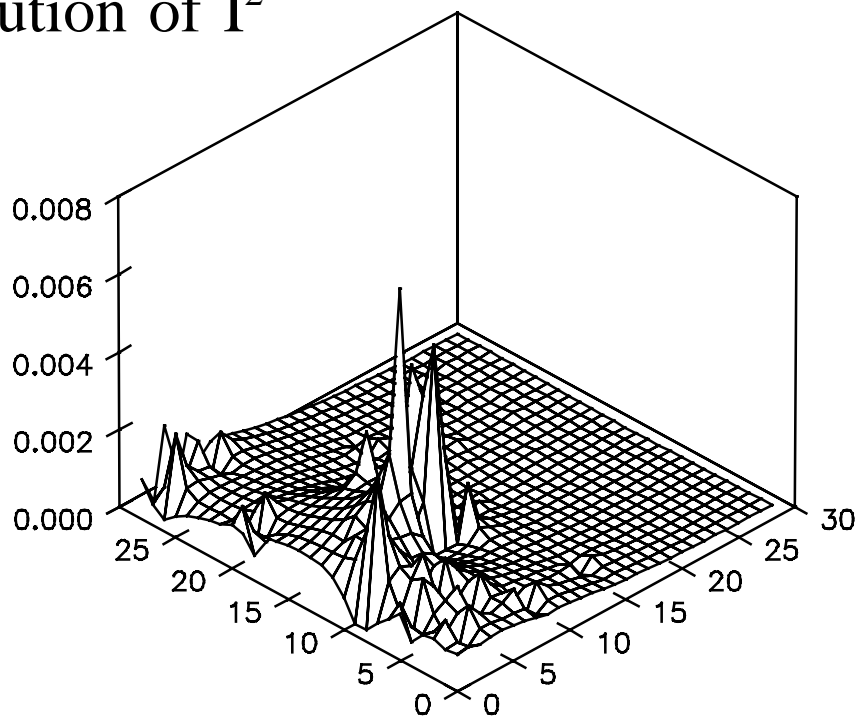
distribution of I^2



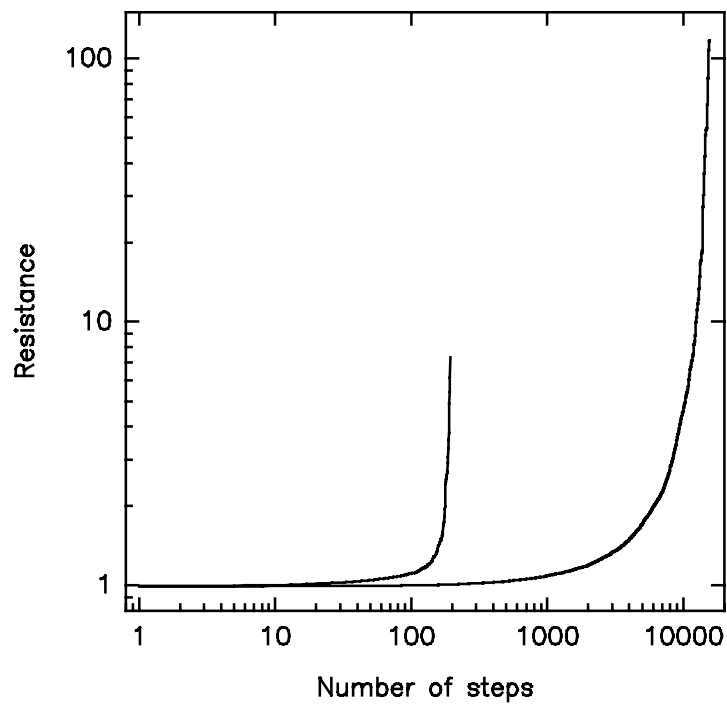
Biased percolation

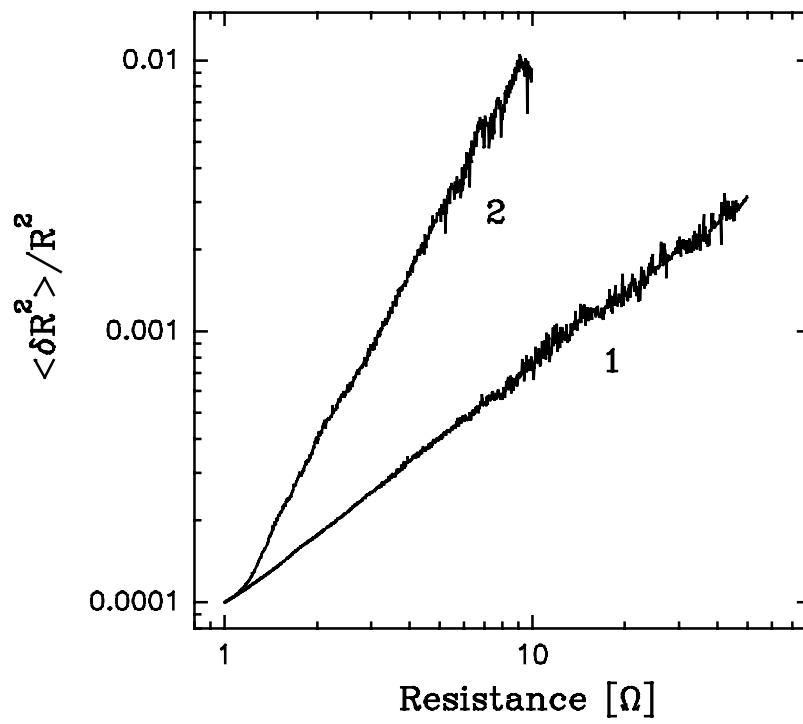
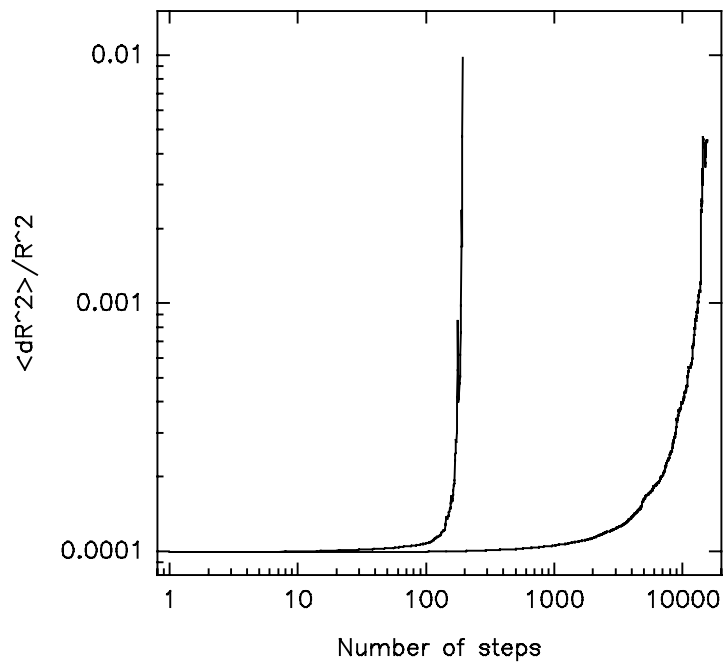


distribution of I^2



Time evolution of sample resistance and noise



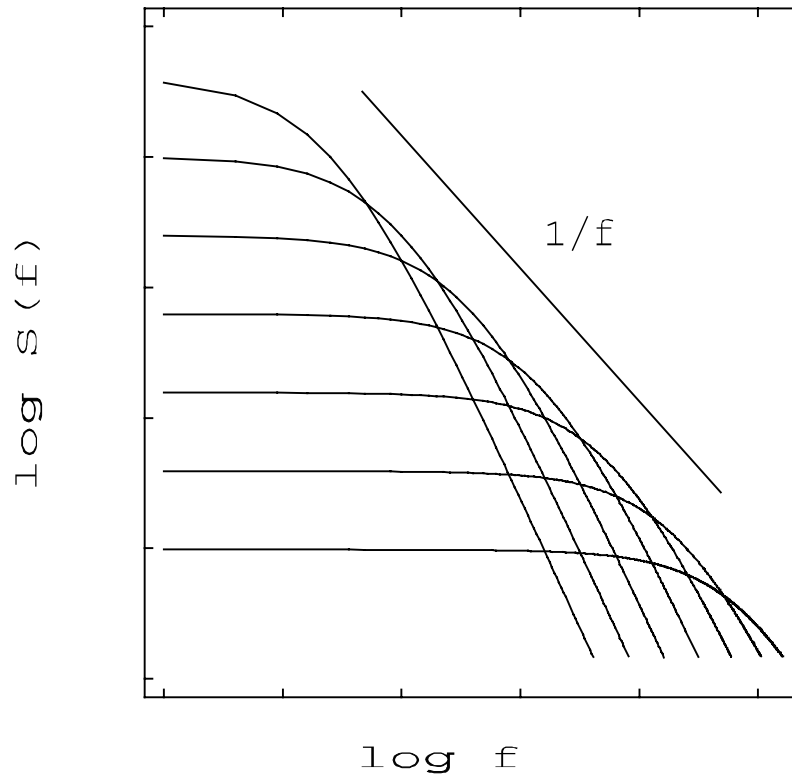


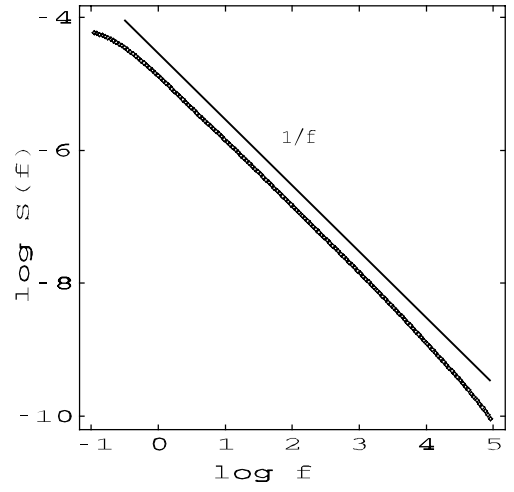
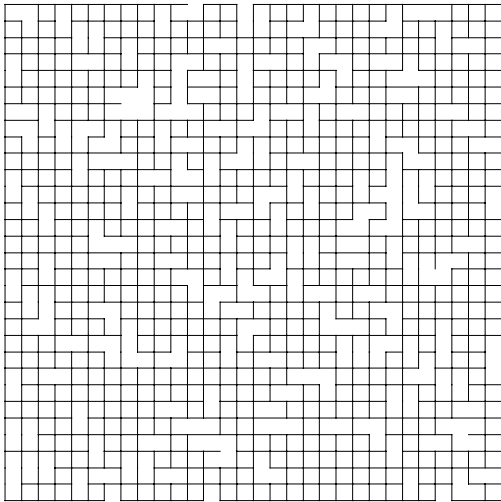
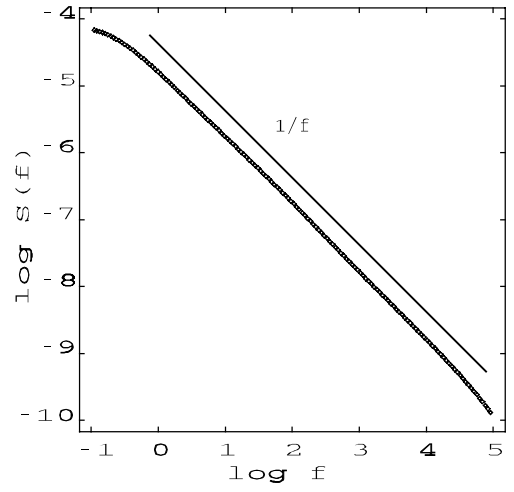
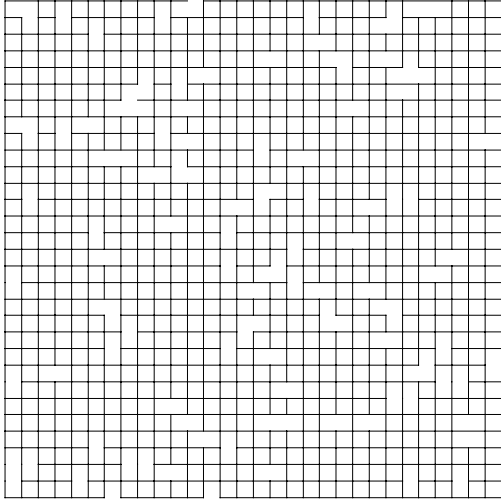
Noise properties

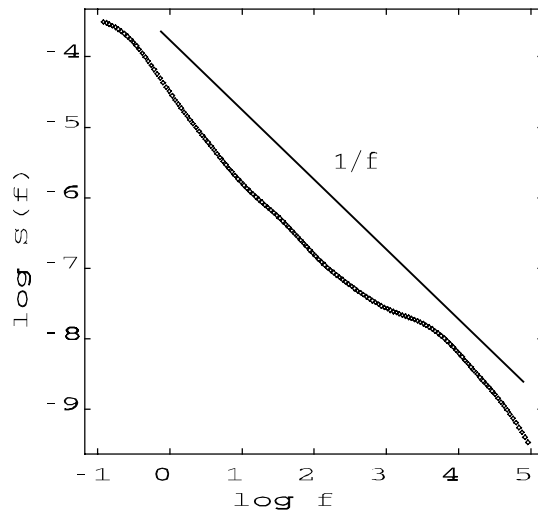
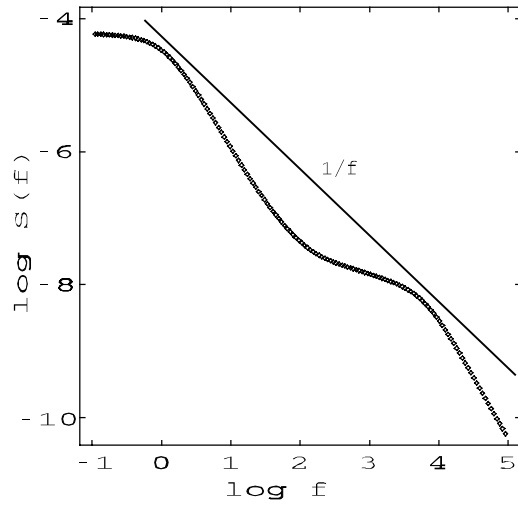
Spatially equally distributed, independent Lorentzian fluctuations with, different correlation times:

$$S(f) = \alpha \int_{\tau_1}^{\tau_2} \frac{\tau g(\tau)}{1 + (2\pi f)^2 \tau^2} d\tau$$

Distribution of τ is $g(\tau)=c/\tau \rightarrow 1/f$ noise.







Results

- A new model for failure of electronic devices based on percolation

MC simulations for free and biased percolation:

- $R(t)$
- Distribution of current density, Joule power
- Noise spectrum of the system

Further development

- noise temperature
- δR vs. R
- how to predict failure of devices using this model
- other structures, e.g. disordered
- 3D modellings